

Wire Wound SMD Power Inductor

♦ Features

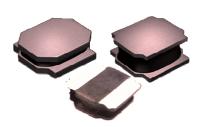
- 1. Magnetic-resin shielded construction reduces buzz noise to ultra-low levels:
- 2. Metallization on ferrite core results in excellent shock resistance and damage-free durability;
- 3. Closed magnetic circuit design reduces leakage
- 4. Small and low profile inductor;
- 5. Take up less PCB real estate and save more power.

Applications

- 1. Smart phone;
- 2. Mobile devices with multifunction such as adding color TV and camera;
- 3. Flat-screen TVs, blue-ray disc recorders, set top boxes:
- 4. Notebooks, desktop computers, servers, graphic cards:
- 5. Portable gaming devices, personal navigation systems, personal multimedia devices;
- 6. Automotive systems;
- 7. Telecomm base stations.

Dimensions





♦ Lead Free Part Numbering

CMLW 3012 P 2R2 M S T (1) (2) (3) (4) (5) (6) (7)

(1) Series Type

(2) Dimension: $L \times W \times H(3.0 \times 3.0 \times 1.2 mm)$

(3) Material Code

(4) Inductance: R47=0.47μH;

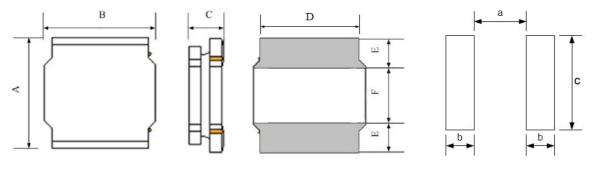
2R2=2.2µH; 100=10µH

(5) Inductance Tolerance: M=±20%, N=±30%

(6) Company Code

(7) Packaging: Tape Carrier Package

Recommended Land Pattern



Unit:mm

Series	A	В	С	D	E	F	а Тур.	b Typ.	с Тур.
CMLW3012P	3.0±0.2	3.0±0.2	1.2Max.	2.6±0.2	0.75±0.2	1.5±0.2	1.5	0.8	3.2

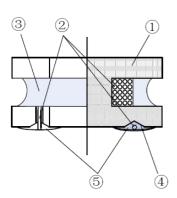
Rev.01 Page 1 of 5 www.cybermaxtech.com.cn



◆ Electrical Characteristics

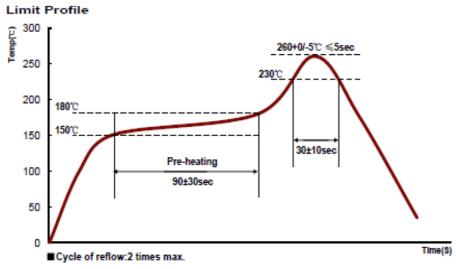
- 1) Operating temperature range (Including self-heating): -40° C ~ +125 $^{\circ}$ C
- 2) Storage temperature range (packaging conditions): -10 $^{\circ}$ C ~+40 $^{\circ}$ C and RH 70% (Max.)

♦ Construction and material

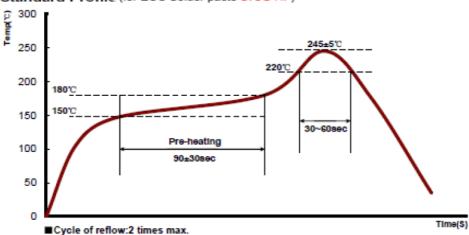


No.	Components	Material
1	Core	Soft magnetic Metal
2	Wire	Polyurethane system enameled copper wire
3	Magnetic Glue	Epoxy resin and magnetic powder
4	substrate	FeNiCu/Ag or Ag/Ni/Sn
(5)	Top Electrodes	Sn alloy
6	Marking	Nitrocellulose

◆ REFLOW-PROFILE







Rev.01 Page 2 of 5 www.cybermaxtech.com.cn



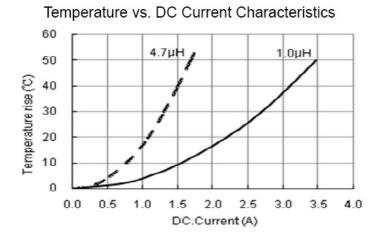
♦ Specification

Part Number	Inductance @1MKHz,0.1V	DC Resistance(m Ω) DCR		Saturation Current Isat		Heat Rating Current Irms	
	(µH)	Тур.	Max.	Max. (A)	Typ. (A)	Max. (A)	Typ. (A)
CMLW3012P Series							
CMLW3012PR22MST	0.22±20%	20	26	10.0	9.30	4.80	4.20
CMLW3012PR33MST	0.33±20%	23	27	8.90	7.20	4.80	4.10
CMLW3012PR47MST	0.47±20%	28	33	8.00	6.80	4.50	3.90
CMLW3012PR68MST	0.68±20%	35	42	6.80	5.80	3.90	3.40
CMLW3012P1R0MST	1.0±20%	45	54	5.40	4.20	3.10	2.70
CMLW3012P1R5MST	1.5±20%	64	74	4.10	3.40	2.90	2.50
CMLW3012P2R2MST	2.2±20%	90	108	3.35	2.80	3.25	2.05
CMLW3012P3R3MST	3.3±20%	129	155	2.60	2.20	2.00	1.70
CMLW3012P4R7MST	4.7±20%	196	235	2.50	2.00	1.50	1.30
CMLW3012P6R8MST	6.8±20%	290	340	1.20	1.45	1.10	1.25
CMLW3012P100MST	10.0±20%	395	474	1.45	1.20	1.15	1.00

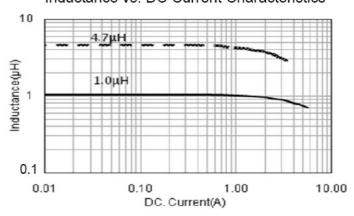
Note

- 1: All test data is referenced to 20°C ambient;
- 2: Rated current: Isat or Irms, whichever is smaller;
- 3: Isat: DC current at which the inductance drops approximate 30% from its value without current;
- 4: Irms: DC current that causes the temperature rise ($\triangle T$ =40°C) from 20°C ambient.

◆ TYPICAL ELECTRICAL CHARACTERISTICS



Inductance vs. DC Current Characteristics





◆ Reliability Test

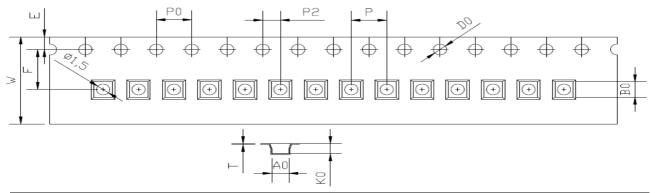
Items	Requirements	Test Methods and Remarks				
A. Terminal Strength	No removal or split of the termination or other defects shall occur.	1) Solder the inductor to the testing jig (glass epo board shown in Fing.7.1-1) using eutectic solder. The apply a force in the direction of the arrow. 2) 10N force. 3) Keep time: 5±2s				
B. High Temperature	No visible mechanical damage. Inductance change: Within ±10%	 Storage Temperature :125+/-5°C Duration : 96 ±4 Hours Recovery : then measured at room ambient temperature after placing 24 hours. 				
C. Low Temperature	No visible mechanical damage Inductance change: Within ±10%	1) Temperature and time: -40±5°C 2) Duration: 96 [±] 4 hours 3) TRecovery: then measured at room ambient temperature after placing 24 hours.				
D. Vibration test	No visible mechanical damage. Inductance change: Within ±10%	1) Frequency range:10HZ~55HZ~10HZ 2) Amplitude:1.5mm p-p 3) Direction:X,Y,Z 4) Time:1 minute/cycle,2hours per axis				
E. High Temperature Storage Tested	No visible mechanical damage. Inductance change: Within ±10%	1) Storage Temperature :60+/-2℃ 2) Relative Humidity :90-95% RH 3) Duration : 96 ±4 Hours 4) Recovery : then measured at room ambient temperature after placing 24 hours.				
F. Resistance to Soldering Heat	1. No visible mechanical damage. 2. Inductance change: Within ±10% 260°C Peak 260°C max Max Ramp Up Rate=3°C/sec. Max Ramp Down Rate=6°C/sec 60~90sec. 150°C Time 25°C to Peak =8 min max Fig. 1	1) Re-flowing Profile: Please refer to Fig. 1 2) Test board thickness: 1.0mm 3) Test board material: glass epoxy resin 4) The chip shall be stabilized at normal condition for 1~2 hours before measuring				
G. Thermal Shock	1. No visible mechanical damage. 2. Inductance change: Within ±10% 105°C 30 min. Ambient Temperature 40°C Max 3 minute Fig. 2	1) Temperature and time: -40±3°C for 30±3 min→105°C for 30±3min, please refer to Fig. 2. 2) Transforming interval: Max, 3 minute 3) Tested cycle: 100 cycles 4) The chip shall be stabilized at normal condition for 1~2 hours before measuring				

Rev.01 Page 4 of 5 www.cybermaxtech.com.cn



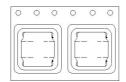
◆Packaging and Marking:

1. Carrier Tape Dimensions:

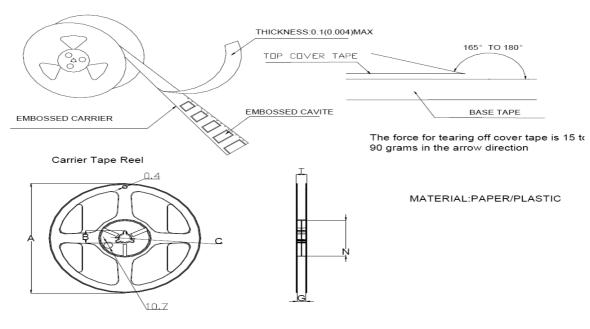


ITEM	W	Α0	В0	K0	Р	F	E	D0	P0	P2	Т
DIM	8.00	3.3	3.3	1.6	4.00	3.50	1.75	1.50	4.00	2.00	0.25
TOLE	±0.1	±0.05	±0.05	±0.1	±0.1	±0.1	±0.1	+0.1	±0.1	±0.1	±0.05

2. Taping Dimensions:



3.Reel Dimensions:



Type	A	В	С	G	N	Т
8mm	178	20.7±0.8	13±0.4	9	60	10.8

4. Packaging Quantity:

Standard Packing Quantity: 2000 pcs/reel

Rev.01 Page 5 of 5 www.cybermaxtech.com.cn